

2.27 Near Infrared Spectrometry

Near infrared spectrometry is one of spectroscopic methods used to qualitatively and quantitatively evaluate samples from the analysis of data obtained by determining their absorption spectrum of light in the near-infrared range.

The near-infrared range lies between the visible light and infrared light, typically of wavelengths (or wave numbers) between 750 and 2500 nm ($13,333$ to 4000 cm^{-1}). The absorption of near-infrared light occurs due to harmonic overtones from normal vibration or combination tones in the infrared range from 2500 to 25000 nm (4000 to 400 cm^{-1}), primarily absorption of O-H, N-H, C-H and S-H that involve hydrogen atoms, in particular.

Absorption in the near-infrared range is far weaker than absorption due to normal vibration that occurs in the infrared range. Furthermore, in comparison with visible light, near-infrared light has longer wavelength, which makes it possible for the light to penetrate to a depth of several mm into solid samples including fine particles. This method is often utilized as a nondestructive analysis, as changes occurring with an absorbed light spectrum (transmitted light or reflected light) in this process provide physical and chemical information pertaining to samples.

Near-infrared spectrometry is used as a rapid and nondestructive method of analysis that replaces conventional and established analysis methods. It is necessary to perform a comparison test to evaluate this method against an existing analysis method, to verify that this method is equivalent to such existing analysis method, before using this analysis method as an evaluation test method for quality control.

Applications of this method include qualitative or quantitative evaluation of active ingredients, additives or water contents of drug substances or preparations. Furthermore, near-infrared spectrometry can also be used for the evaluation of physical conditions of substances, such as crystal forms, crystallinity, particle diameters. It is also possible to perform spectrometry on samples that are located in a remote location away from equipment main units, without sampling, by using optical fibers. It can therefore be used as an effective means to perform pharmaceutical manufacturing process control online (or in-line).

1. Equipment

Near-infrared spectrophotometers mainly include a distributed near-infrared spectrophotometer and a Fourier transform near-infrared spectrophotometer.

1.1. Distributed near-infrared spectrophotometer

This equipment is comprised of a light source section, sample section, spectrometry section, photometry section, signal processing section, data processing section, and display-record output section. Halogen lamps, tungsten lamps,

light emitting diodes and other such devices that can emit high intensity near-infrared light in a stable manner are used in the light source section. The sample section is comprised of a sample cell and a sample holder. Equipment with an optical fiber section that is comprised of optical fibers and a collimator is equipped with a function for transmitting light to the sample section, which is remotely located away from the spectrophotometer main unit. Quartz is ordinarily used as material for optical fibers.

The spectrometry section is intended to extract light of required wavelength, using dispersive devices and is comprised of slits, mirrors and dispersive devices. The photometry section is comprised of detectors and amplifiers. Sensors include semiconductor detectors, as well as photomultiplier tubes. Detecting methods that use semiconductor detectors generally perform detections with single elements, but there are also occasions where array type detectors that use multiple elements are used. Such detectors are capable of simultaneously detecting multiple wavelengths (or wave numbers). The signal processing section separates signals required for measurements from output signals fed by amplifiers and then outputs such isolated signals. The signal processing methods include analog processing and digital processing.

1.2. Fourier transform near-infrared spectrophotometer

The configuration of the equipment is fundamentally the same as that of the distributed-type equipment described in Section 1.1., except for the spectrophotometry section and the signal processing section.

The spectrophotometry section is comprised of interferometers, sampling signal generators, detectors, amplifiers, A/D conversion devices, etc. The signal processing section is equipped with functions that are required for the spectrometer, as well as a function for translating an acquired interference waveform (interferogram) into an absorption spectrum by Fourier transformation.

2. Measurement method

There are three types of measurement methods that are used with near-infrared spectrometry: transmittance method, diffuse reflectance method and transmittance reflectance method. The selection of measurement methods relies on the shape of samples and applications. For example, the transmittance method or diffuse reflectance method is used for solid samples, including fine particles, and the transmittance method or transmittance reflectance method is used for liquid samples. The measurement mode, etc. of equipment are selected and set.

2.1. Transmittance method

The degree of decay for incident light intensity as the light from a light source passes through a sample, is represented as transmittance rate T (%) or absorbance A with the transmittance method.

103 This method is applied for taking measurements of sam-
 104 ples that are liquids and solutions. Quartz glass cells and flow
 105 cells are used, with the layer length of 1-5 mm along. Fur-
 106 thermore, this method can also be applied for taking meas-
 107 urements of samples that are solids including fine particles.
 108 It is also known as the diffuse transmittance method. Select-
 109 ing appropriate layer length is critical for this method, since
 110 the transmitted light intensity varies depending on grain sizes
 111 and surface condition of samples.

112 2.2. Diffuse reflectance method

113 The ratio of reflection light intensity I emitted from a sam-
 114 ple in a wide reflectance range and control reflection light
 115 intensity I_r emitted from the surface of a control substance is
 116 expressed as reflectance R (%) with the diffuse reflectance
 117 method. The near-infrared light penetrates to a depth of sev-
 118 eral mm into solid samples including fine particles. In that
 119 process, transmission, refraction, reflection and dispersion
 120 are repeated, and diffusion takes place, but a portion of the
 121 diffused light is emitted again from the surface of the sample
 122 and captured by a detector. The spectrum for the diffuse re-
 123 flectance absorbance (A_r) can ordinarily be obtained by plot-
 124 ting logarithm of inverse numbers for reflectance against
 125 wavelengths (or wave numbers).

126 This method is applied to solid samples including fine par-
 127 ticles, and requires a diffuse reflector such as a probe.

128 2.3. Transmittance reflectance method

129 The transmittance reflectance method is a combination of
 130 the transmittance method and reflectance method. A mirror
 131 is used to re-reflect the light that has passed through a sample
 132 in order to measure transmittance reflectance rate, T^* (%).
 133 The light path must be twice the thickness of the sample. On
 134 the other hand, the light reflected by a mirror and being in-
 135 troduced into a detector is used as the control light. When this
 136 method is applied to suspended samples, however, a metal
 137 plate or a ceramic reflector with a rough surface that causes
 138 diffuse reflectance is used instead of a mirror.

139 This is a method that is applied to solid samples, including
 140 fine particles, as well as liquids and suspended samples. The
 141 thickness of a sample must be adjusted when applying this
 142 method to a solid sample. Ordinarily adjustment is made by
 143 setting absorbance to 0.1 – 2 (transmittance of 79 – 1%),
 144 which provides the best linearity and SN ratio of a detector.
 145 A cell with appropriate layer length, according to the grain
 146 size of the fine particle, must be selected when applying the
 147 method to a fine particle sample.

148 3. Factors that affect spectra

149 Following items must be considered as factors that can af-
 150 fect spectra when applying near-infrared spectrometry, par-
 151 ticularly when conducting quantitative analysis.

152 (i) Measurement conditions: A significant change
 153 (wavelength shift, for example) can occur when the temper-
 154 ature varies by a several degrees (°C). Care must be taken,

155 particularly when a sample contains water. Also, water or re-
 156 sidual solvent contents of a sample, as well as water (humid-
 157 ity) in the environment where in measurements are taken, can
 158 significantly affect absorption bands of the near-infrared
 159 range.

160 The thickness of a sample is a factor for spectral changes
 161 and therefore needs to be controlled at a certain thickness.
 162 Furthermore, since the condition of sample fill can poten-
 163 tially affect spectra when taking measurements of samples
 164 that are solids or fine particles, care must be taken with filling
 165 samples in a cell, to ensure that a certain amount is filled
 166 through a specific procedure.

167 Samples can potentially undergo chemical, physical or op-
 168 tical property changes, due to passing of time or storage after
 169 sampling. In creating calibration curves, therefore, it is nec-
 170 essary to pay attention that the samples for calibration curves
 171 must be prepared with adequate considerations for reducing
 172 the time to be measured, such as the measurement is carried
 173 out offline in a laboratory or online in manufacturing process
 174 (or inline).

175 (ii) Characteristics of samples: When a sample is physi-
 176 cally, chemically or optically uneven, relatively large beam
 177 size must be used, multiple samples must be used, measure-
 178 ments must be taken at multiple points on the same samples,
 179 or a sample must be pulverized to ensure averaging of the
 180 sample. Grain size, fill condition, as well as roughness of sur-
 181 faces can also affect the spectra of fine particle samples.
 182 Since variations in crystal structures (crystal polymorphism)
 183 can also affect spectra, in cases where multiple crystal forms
 184 exist, care must be taken to ensure that even standard samples
 185 for the calibration curve method have diversified distribu-
 186 tions similar to that of samples to be analyzed.

187 4. Control of equipment performance

188 4.1. Accuracy of wavelengths (or wave numbers)

189 The accuracy of wavelengths (or wave numbers) of equip-
 190 ment is derived from the deviation of suitable substances for
 191 which peak absorption wavelengths (or wave numbers) have
 192 been defined, such as polystyrene, mixture of rare earth ox-
 193 ides (dysprosium, holmium and erbium; 1:1:1) or steam,
 194 from the figures indicated on the equipment. Tolerance fig-
 195 ures in the vicinity of 3 peaks are ordinarily set in the follow-
 196 ing manner, though appropriate tolerance figures can be set
 197 depending on the intended purpose:

198 $1200 \pm 1 \text{ nm}$ ($8300 \pm 8 \text{ cm}^{-1}$)

199 $1600 \pm 1 \text{ nm}$ ($6250 \pm 4 \text{ cm}^{-1}$)

200 $2000 \pm 1.5 \text{ nm}$ ($5000 \pm 4 \text{ cm}^{-1}$)

201 Since the location of absorption peaks vary, depending on
 202 the substance used as reference, absorption peaks of wave-
 203 lengths (or wave numbers) that are closest to the above 3
 204 peaks are selected for suitability evaluation. A mixture of rare

205 earth oxides, for instance, would indicate characteristic ab-
206 sorption peaks at 1261 nm (7930 cm^{-1}), 1681 nm (5949 cm^{-1}) and 1971 nm (5074 cm^{-1}).

208 The absorption peak of steam at 1368.6 nm (7306.7 cm^{-1})
209 can be used with a Fourier transformation type spectropho-
210 tometer, as its wave number resolution ability is high.

211 Other substances can also be used as the reference, so long
212 as their adequacy for the purpose can be verified.

213 4.2. Spectroscopic linearity

214 Appropriate standard plates, such as plate-shaped polymer
215 impregnated with varying concentrations of carbon (Carbon-
216 doped polymer standards), can be used to evaluate spectro-
217 scopic linearity. In order to verify linearity, however, stand-
218 ard plates with no less than 4 levels of concentration within
219 the reflectance of 10 – 90% must be used. When measure-
220 ments are expected to be taken with absorbance of not less
221 than 1.0, it is necessary to add standard plates with the reflec-
222 tance of either 2% or 5% or both.

223 In order to plot absorbance of such standard plates at loca-
224 tions in the vicinity of wavelengths 1200 nm (8300 cm^{-1}),
225 1600 nm (6250 cm^{-1}) and 2000 nm (5000 cm^{-1}) against ab-
226 sorbance at each wavelength (or wave number) assigned to
227 each standard plate, ensure that the gradient of linearity and
228 ordinate intercept obtained are ordinarily within the ranges of
229 1.00 ± 0.05 and 0.00 ± 0.05 , respectively. Depending on
230 the intended purpose, appropriate tolerance figures can be set.

231 5. Application of qualitative or quantitative analysis

232 Ordinarily, chemometrics methods are used for analyzing
233 a near-infrared absorption spectrum. Conventional spectro-
234 metric methods, such as a calibration curve method, may be
235 used as a method whenever applicable. Chemometrics ordi-
236 narily involve the quantification of chemical data, as well as
237 numerical and statistical procedures for computerization of
238 information. Various types of multivariate analysis are used
239 as chemometrics for near infrared spectrometry, and are se-
240 lected according to the intended purpose. Characteristics of
241 near-infrared absorption spectrum must be emphasized and
242 effects of complexities of spectra, as well as overlay of ab-
243 sorption bands must be reduced by performing mathematical
244 preprocesses, such as primary or secondary spectral differen-
245 tiation processes or normalizations, which becomes one of
246 vital procedures in establishing analysis methods that use
247 methodologies of chemometrics.

248 In near-infrared spectroscopy, sustaining and managing
249 performance of an analysis method, once established, are
250 critical. Continuous and systematic maintenance and inspec-
251 tion work are required. Furthermore, it is necessary to pay
252 attention to whether or not appropriate evaluation procedures
253 are available to deal with change controls or implementation
254 of re-validation on changes made in manufacturing processes
255 or raw materials, as well as changes arising from replacement
256 of major components in equipment.

257 5.1. Qualitative analysis

258 Qualitative analysis is performed for each substance to be
259 analyzed after preparing a reference library that includes in-
260 ter-lot variations within the tolerance range and establishing
261 an analysis method using chemometrics methodology. The
262 identity of substances can be confirmed by comparison with
263 a standard spectrum or by methods using validated chemo-
264 metrics software. Also, substances can be identified by their
265 absorbance bands.

266 Furthermore, multivariate analysis includes direct analysis
267 methods that consider wavelengths (or wave numbers) and
268 absorption as variables, such as wavelength correlation
269 method, residual sum of squares, range sum of squares, along
270 with factor analysis method, cluster analysis method, discrimi-
271 nant analysis method and SIMCA (Soft independent mod-
272 eling of class analogy) that are applied after processing such
273 as principal component analysis.

274 It is also possible to consider the overall near-infrared ab-
275 sorption spectrum as a single pattern and to identify paramet-
276 ers obtained by applying multivariate analysis methods or
277 characteristic wavelength (or wave number) peaks of compo-
278 nents to be analyzed as indices for monitoring, for the pur-
279 pose of manufacturing process control for drug substances or
280 preparations.

281 5.2. Quantitative analysis

282 Quantitative analysis ordinarily uses spectra of sample
283 groups and analysis values obtained through the existing and
284 established analysis methods, to obtain quantitative models
285 with methodologies of chemometrics. These are used to cal-
286 culate concentrations of individual ingredients and material
287 values of samples being measured, using conversion formu-
288 las. Chemometrics methodologies for obtaining quantitative
289 models include multiple regression analysis method and PLS
290 (Partial least squares) regression analysis method.

291 In cases where the composition of a sample is simple, con-
292 centrations of ingredients in the sample to be analyzed can be
293 calculated by plotting a calibration curve using the absorb-
294 ance of a specific wavelength (or wave number) or the corre-
295 lating relationship between the parameters and concentration,
296 using samples for preparation of calibration curves with
297 known concentrations (calibration curve method).